Search Notes



_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/710,935	CHEN ET AL.	
	Examiner	Art Unit	
	DAVID VU	2818	

SEARCHED					
Class	Subclass	Date	Examiner		
257	315-319; 365; E29.129	10/11/2006	DV		
	E29.3	10/11/2006	DV		
	E21.68	10/11/2006	DV		
438	257, 266	10/11/2006	DV		
Updated		3/27/2007	DV		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE E	XMR		
EAST	10/11/2006	DV		
EAST	10/11/2006	DV		
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